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FORM PTO-1449 (REV. 6-89) INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)	U.S. DEPARTMENT OF COMMERCE Patent and Trademark Office		Attorney's Docket No. 4764	Serial No. 09/502,120
	Applicant Dan Meisburger, et al.			
	Filing Date 2/10/00		Group Art Unit 2878	

U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
<i>kn</i>	A	3 7 9 5 8 0 9	03/05/74	Takashima	—	—	
	B	3 8 0 9 8 9 9	5/7/74	Baker et al.	—	—	
	C	3 8 4 5 3 0 5	10/29/74	Liebl	—	—	
	D	4 1 0 1 7 7 1	07/18/78	Hofer et al.	—	—	
	E	4 2 4 7 2 0 3	01/27/81	Levy et al.	—	—	
	F	4 3 6 2 9 4 2	12/07//82	Yasuda	—	—	
	G	4 4 3 8 3 3 2	03/20/84	Lichtenegger	—	—	
	H	4 5 0 3 3 2 9	03/05/85	Yamaguchi et al.	—	—	
	I	4 5 0 8 9 6 8	04/02/85	Kobayashi et al.	—	—	
	J	4 6 0 9 8 0 9	09/02/86	Yamaguchi et al.	—	—	
<i>kn</i>	K	4 6 1 8 9 3 8	10/21/86	Sandland et al.	—	—	

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER <i>h. Nguyen</i>	DATE CONSIDERED <i>07-24-01</i>
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LN	L	4 6 4 4 1 7 2	02/17/87	Sandland et al.	—	—	
LN	M	4 6 5 8 1 3 6	04/14/87	Ohtaka et al.	—	—	
LN	N	4 6 5 8 1 3 8	04/14/87	Koike et al.	—	—	
	O	4 6 6 5 3 1 5	05/12/87	Bacchetti et al.	See PTO 1449 filed on 11/06/00		
LN	P	4 7 1 4 8 3 3	12/22/87	Rose et al.	—	—	
	Q	4 7 6 9 5 4 3	09/06/88	Plies	—	—	
	R	4 8 0 5 1 2 3	02/14/89	Specht et al.	—	—	
	S	4 8 1 2 6 5 1	3/14/89	Feuerbaum et al.	—	—	
	T	4 8 1 4 6 1 5	03/21/89	Fushimi et al.	—	—	
	U	4 8 1 8 8 8 5	04/04/89	Davis et al.	—	—	
LN	V	4 8 3 1 2 6 6	05/16/89	Frosien et al.	—	—	

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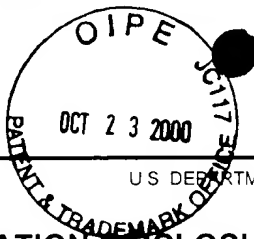
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09/502,120

INFORMATION DISCLOSURE CITATION

Applicant

Dan Meisburger, et al.

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LN	W	4 8 4 5 5 5 8	07/4/89	Tsai et al.	—	—	
	X	4 8 6 8 3 9 5	09/19/89	Kasahara et al.	—	—	
	Y	4 8 7 1 9 1 1	10/03/89	Van Gorkom et al.	—	—	
	Z	4 8 9 6 0 3 6	01/23/90	Rose et al.	—	—	
	AA	4 9 2 4 1 0 4	05/08/90	Stengl et al.	—	—	
	BB	4 9 2 6 4 8 7	05/15/90	Yoshida et al.	—	—	
	CC	4 9 2 6 4 8 9	05/15/90	Danielson et al.	—	—	
	DD	4 9 3 3 5 6 5	06/12/90	Yamaguchi et al.	—	—	
	EE	4 9 3 9 3 6 4	07/03/90	Ishitani et al.	—	—	
	FF	4 9 5 4 7 0 5	09/04/90	Brunner et al.	—	—	
LN	GG	4 9 5 8 0 7 4	09/18/90	Wolf et al.	—	—	

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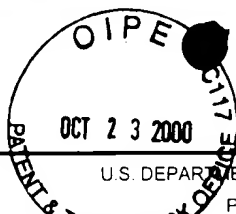
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LN	HH	5 1 1 7 1 1 1	05/26/92	Nakamura et al.	—	—	
	II	5 1 1 8 9 4 1	06/02/92	Larson	—	—	
	JJ	5 1 2 2 6 6 3	06/16/92	Chang et al.	—	—	
	KK	5 1 4 2 1 4 8	08/25/92	Sato	—	—	
	LL	5 2 5 4 8 5 7	10/19/93	Ross et al.	—	—	
	MM	5 5 0 2 3 0 6	03/26/96	Meisburger et al.	—	—	
LN	NN	5 5 7 8 8 2 1	11/26/96	Meisburger et al.	—	—	

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							Yes No

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

LN	OO	Herriott, Donald R., et al., EBES: A Practical Electron Lithographic System, IEEE Transactions on Electron Devices, Vol. ED-22, No. 7, July 1975, pp. 385,392
LN	PP	Koshishiba, Hiroya, et al., Pattern Inspection of X-Ray Mask Using Scanning Transmission Electron Microscope, Japan Journal of Application Physics, Issue 12, 1989
LN	QQ	Andersen, W., Optimum Adjustment and Correction of the Wien Filter, Brit. J. Appl. Phys., 1967, Vol. 18, pp. 1573-1579
LN	RR	Curtis, G. H., et al., A Wien Filter for Use as an Energy Analyzer with an Electron Microscope, The Review of Scientific Instruments, Volume 42, Number 5, May 1971, pp. 630-637

EXAMINER LN ALGUYEN

DATE CONSIDERED 11-24-01

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